

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LIN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP8-119864	05-1996	Japan	Takahashi et al.	A61K 31/575
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NON-PATENT DOCUMENTS

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